


10/651665 Examiner: LEBENTRITT, MICHAEL GAU: 2824
Classification: 438/014.000 Inventor: SIMMONS, STEVEN
Status: 71 - RESPONSE TO NON-FINAL OFFICE ACTION ENTERED AND FORWARDED TO EXAMINER
Title: YIELD BASED, IN-LINE DEFECT SAMPLING METHOD

Bib Data report

Application Title: YIELD BASED, IN-LINE DEFECT SAMPLING METHOD			
Application Num:  (in phx) <u>10651665</u>		Filing Date: 08/29/2003	
Effective Filing 08/29/2003			
<u>(Location History)</u>		<u>(Foreign/Continuity Data)</u>	
Status: 71/RESPONSE TO NON-FINAL OFFICE ACTION ENTERED AND FORWARDED TO EXAMINER Status Date: 09/29/2004			
Patent Number: Not Issued		Issue Date: N/A	Date of Abandonment: N/A
Confirmation Number: 9328		PALM Location:	
Examiner: 73858 LEBENTRITT, MICHAEL <u>Assignment Data</u>) Group Art			
Unit: 2824 Class/Subclass: 438/014.000			
State or Country: IDAHO Sheets/Drawing: 5 Total Claims: 18			
Independent Claims: 3			
Inventors:			
Last name, First name:		City:	Country or State:
SIMMONS, STEVEN		BOISE	IDAHO
Attorneys: <u>ALL</u> Attorney Docket No: <u>3640.2US (97-1175.02/US)</u>			
Interference No:		Lost Case: No	Unmatched Petition: No L&R Code: 1